



## UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE  
 United States Patent and Trademark Office  
 Address: COMMISSIONER FOR PATENTS  
 P.O. Box 1450  
 Alexandria, Virginia 22313-1450  
[www.uspto.gov](http://www.uspto.gov)

## BIB DATA SHEET

CONFIRMATION NO. 2711

SERIAL NUMBER	FILING or 371(c) DATE	CLASS	GROUP ART UNIT	ATTORNEY DOCKET NO.
10/587,645	07/27/2006 RULE	365 324	2829	NL040019US1

**APPLICANTS**

Andrea Scarpa, Wijchen, NETHERLANDS;  
 Paul H. Cappon, Wijchen, NETHERLANDS;  
 Peter C. De Jong, Arnhem, NETHERLANDS;  
 Taede Smedes, Beuningen, NETHERLANDS;

**\*\* CONTINUING DATA \*\*\*\*\***

This application is a 371 of PCT/IB05/50347 01/27/2005 verified /JMB/

**\*\* FOREIGN APPLICATIONS \*\*\*\*\***

EUROPEAN PATENT OFFICE (EPO) 04100289.0 01/28/2004 verified /JMB/

**\*\* IF REQUIRED, FOREIGN FILING LICENSE GRANTED \*\***

04/07/2007

Foreign Priority claimed	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	<input type="checkbox"/> Met after Allowance	STATE OR COUNTRY	SHEETS DRAWINGS	TOTAL CLAIMS	INDEPENDENT CLAIMS
35 USC 119(a-d) conditions met	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No		NETHERLANDS	6	13	2
Verified and Acknowledged	JEROME M HOLLINGTON/ Examiner's Signature	Initials				

**ADDRESS**

NXP, B.V.  
 NXP INTELLECTUAL PROPERTY DEPARTMENT  
 M/S41-SJ  
 1109 MCKAY DRIVE  
 SAN JOSE, CA 95131  
 UNITED STATES

**TITLE**

Method and apparatus for testing integrated circuits for susceptibility to latch-up

<b>FILING FEE RECEIVED</b> 900	FEES: Authority has been given in Paper No._____ to charge/credit DEPOSIT ACCOUNT No._____ for following:	<input type="checkbox"/> All Fees
		<input type="checkbox"/> 1.16 Fees (Filing)
		<input type="checkbox"/> 1.17 Fees (Processing Ext. of time)
		<input type="checkbox"/> 1.18 Fees (Issue)
		<input type="checkbox"/> Other _____
		<input type="checkbox"/> Credit